


<b>Search Notes</b>  	<b>Application/Control No.</b>  10585638	<b>Applicant(s)/Patent Under Reexamination</b>  OHNO ET AL.
	<b>Examiner</b>  JONATHAN HAN	<b>Art Unit</b>  4176

SEARCHED			
Class	Subclass	Date	Examiner
257	421	12/01/2008	Jonathan Han
257	295	12/1/2008	Jonathan Han
257	E43.001	12/1/2008	Jonathan Han
257	E43.005	12/1/2008	Jonathan Han
257	E29.167	12/1/2008	Jonathan Han
257	E29.323	12/1/2008	Jonathan Han

SEARCH NOTES		
Search Notes	Date	Examiner
Reviewed IDS and ISR form	12/01/2008	Jonathan Han
Performed Inventor and Assignee Search via eDAN	12/01/2008	Jonathan Han
Performed Class/Subclass Search (see attached EAST Search History)	12/01/2008	Jonathan Han
Performed Text Search	12/01/2008	Jonathan Han

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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Examiner, Art Unit 4176